

**Notice of References Cited**

Application/Control No.

10/571,288

Applicant(s)/Patent Under  
Reexamination  
HEEB ET AL.

Examiner

Nicholas P. D'Aniello

Art Unit

1793

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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